Notice of References Cited	Application/Control No. 10/677,025	Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Fikremariam Yalew	Art Unit 2136	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,138,239	10-2000	Veil, Leonard Scott	726/10
*	B	US-7,003,672	02-2006	Angelo et al.	713/189
*	C	US-7,107,493	09-2006	Nguyen et al.	714/42
*	D	US-6,678,625	01-2004	Reise et al.	702/117
*	E	US-2004/0153644	08-2004	McCorkendale et al.	713/156
*	F	US-6,880,107	04-2005	Kraft, IV, George	714/36
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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